D2804, MARCH 1984-REVISED SEPTEMBER 1987

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

description

These devices contain a single 8-input OR/NOR gate and perform the following Boolean functions in positive logic:

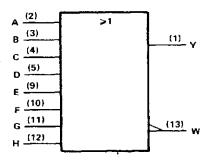
$$W = \overline{A + B + C + D + E + F + G + H}$$
or
$$W = \overline{A} \cdot \overline{B} \cdot \overline{C} \cdot \overline{D} \cdot \overline{E} \cdot \overline{F} \cdot \overline{G} \cdot \overline{H}$$
and
$$Y = A + B + C + D + E + F + G + H$$
or
$$Y = \overline{A} \cdot \overline{B} \cdot \overline{C} \cdot \overline{D} \cdot \overline{E} \cdot \overline{F} \cdot \overline{G} \cdot \overline{H}$$

The SN54HC4078A is characterized for operation over the full military temperature range of $-55\,^{\circ}\text{C}$ to 125 $^{\circ}\text{C}$. The SN74HC4078A is characterized for operation from $-40\,^{\circ}\text{C}$ to 85 $^{\circ}\text{C}$.

FUNCTION TABLE

INPUTS A	OUTPUTS				
THRU H	w	Υ			
One or more inputs H	L	Н			
All inputs L	н	L			

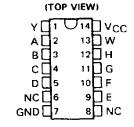
logic symbol†



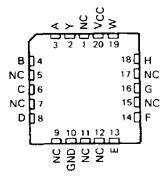
¹This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

SN54HC4078A . . . J PACKAGE SN74HC4078A . . . D OR N PACKAGE

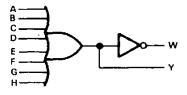


SN54HC4078A . . . FK PACKAGE (TOP VIEW)



NC-No internal connection

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range†

Supply voltage, VCC	0.5	V to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)		± 20 mA
Output clamp current, IOK (VO < 0 or VO > VCC)		± 20 mA
Continuous output current, Io (Vo = 0 to Vcc)		±25 mA
Continuous current through VCC or GND pins		± 50 mA
Lead temperature 1,6 mm (1/16 in) from case for 60 s: FK or J package		. 300°C
Lead temperature 1,6 mm (1/16 in) from case for 10 s: D or N package		. 260°C
Storage temperature range65		

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

			SN54HC4078A			SN74HC4078A			
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		2	5	6	2	5	6	٧
		V _{CC} = 2 V	1.5			1.5			
V_{IH}	High-level input voltage	V _{CC} = 4.5 V	3.15			3.15			V
		V _{CC} = 6 V	4.2			4.2			
	** · · •	V _{CC} = 2 V	0		0.3	0		0.3	
V_{IL}	Low-level input voltage	$V_{CC} = 4.5 V$	0		0.9	0		0.9	V
		$V_{CC} = 6 V$	0		1.2	0		1.2	
VI	V _I Input voltage		0		Vcc	0		Vcc	٧
٧o	Output voltage		0		VCC	0		VCC	V
	-	V _{CC} = 2 V	0		1000	0		1000	
tt	Input transition (rise and fall) times	$V_{CC} = 4.5 V$	0		500	0		500	ns
		V _{CC} = 6 V	0		400	0		400	
TA	Operating free-air temperature		- 55		125	- 40		85	ů

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	vcc	TA = 25°C			SN54HC4078A		SN74HC4078A		UNIT
	TEST CONDITIONS		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
∨он		2 V	1.9	1.998		1.9		1.9		
	$V_{\parallel} = V_{\parallel H} \text{ or } V_{\parallel L}, I_{OH} = -20 \mu\text{A}$	4.5 V	4.4	4.499		4.4		4.4		
		6 V	5.9	5.999		5.9		5.9		V
	$V_I = V_{IH}$ or V_{IL} , $I_{OH} = -4$ mA	4.5 V	3.98	4.30		3.7	•	3.84		
	$V_I = V_{IH}$ or V_{IL} , $I_{OH} = -5.2$ mA	6 V	5.48	5.80		5.2		5.34		
VOL		2 V		0.002	0.1	1	0.1		0.1	
	$V_{I} = V_{IH}$ or V_{IL} , $I_{OL} = 20 \mu A$	4.5 V		0.001	0.1		0.1		0.1	
		6 V		0.001	0.1		0.1		0.1	ν
	$V_I = V_{IH}$ or V_{IL} , $I_{OL} = 4$ mA	4.5 V		0.17	0.26		0.4		0.33	
	VI = VIH or VIL, IOL = 5.2 mA	6 V		0.15	0.26	1	0.4		0.33	
կ	VI = VCC or O	6 V		±0.1	± 100		± 1000	t	1000	nΑ
¹ CC	$V_1 = V_{CC}$ or 0, $I_0 = 0$	6 V			8		160		80	μA
Ci		2 to 6 V		3	10	İ	10		10	ρF

25 pF typ

switching characteristics over recommended operating free-air temperature range (unless otherwise noted), C_L = 50 pF (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	Vcc	TA = 25°C			SN54H	C4078A	SN74HC4078A		1.15.15.7
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		40	130		195	1	165	
^t pd	A thru H	Y/W	4.5 V		12	26		39		33	ns
			6 V	i	10	22		33	į	28	
t _t			2 V		38	75		110		95	
	i	Y/W	4.5 V		8 15 22		19	ns			
			6 V	Ī	6	13	}	19		16	

No load, TA = 25°C

Note 1: Load circuits and voltage waveforms are shown in Section 1.

Power dissipation capacitance per gate

Cpd

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